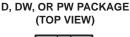
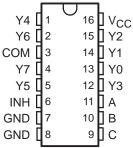
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- Controlled Baseline
 - One Assembly/Test Site, One Fabrication Site
- Extended Temperature Performance of -40°C to 105°C
- Enhanced Diminishing Manufacturing Sources (DMS) Support
- Enhanced Product-Change Notification
- Qualification Pedigree[†]
- 2-V to 5.5-V V_{CC} Operation
- Supports Mixed-Mode Voltage Operation on All Ports
- High On-Off Output-Voltage Ratio
- Low Crosstalk Between Switches
- † Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85, temperature cycle, autoclave or unbiased HAST, electromigration, bond intermetallic life, and mold compound life. Such qualification testing should not be viewed as justifying use of this component beyond specified performance and environmental limits.

- Individual Switch Controls
- Extremely Low Input Current
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)





description/ordering information

This 8-channel CMOS analog multiplexer/demultiplexer is designed for 2-V to 5.5-V V_{CC} operation.

The SN74LV4051A handles both analog and digital signals. Each channel permits signals with amplitudes up to 5.5 V (peak) to be transmitted in either direction.

Applications include signal gating, chopping, modulation or demodulation (modem), and signal multiplexing for analog-to-digital and digital-to-analog conversion systems.

ORDERING INFORMATION

TA	PACK	AGE‡	ORDERABLE PART NUMBER	TOP-SIDE MARKING
	SOIC - D	Tape and reel	SN74LV4051ATDREP	LV4051ATEP
-40°C to 105°C	SOIC - DW	Tape and reel	SN74LV4051ATDWREP§	LV4051ATEP
	TSSOP - PW	Tape and reel	SN74LV4051ATPWREP	L4051EP

[‡]Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

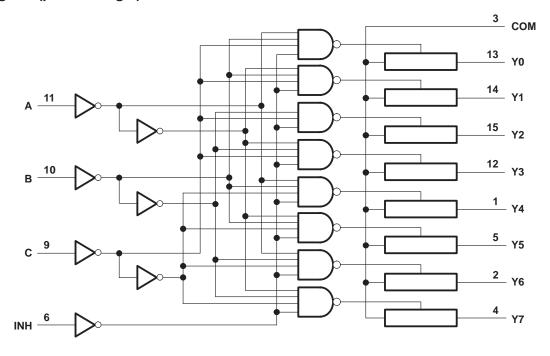


[§] Product Preview.

FUNCTION TABLE

	INP	UTS		ON
INH	С	В	Α	CHANNEL
L	L	L	L	Y0
L	L	L	Н	Y1
L	L	Н	L	Y2
L	L	Н	Н	Y3
L	Н	L	L	Y4
L	Н	L	Н	Y5
L	Н	Н	L	Y6
L	Н	Н	Н	Y7
Н	Χ	Χ	Χ	None

logic diagram (positive logic)



SN74LV4051A-EP 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

	0 = 1/4 = 0.1/
Supply voltage range, V _{CC}	
Input voltage range, V _I (see Note 1)	
Switch I/O voltage range, V _{IO} (see Notes 1 and 2)	0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0)	
I/O diode current, I_{IOK} ($V_{IO} < 0$)	–50 mA
Switch through current, $I_T (V_{IO} = 0 \text{ to } V_{CC})$	±25 mA
Continuous current through V _{CC} or GND	±50 mA
Package thermal impedance, θ_{JA} (see Note 3): D package .	73°C/W
DW package	57°C/W
PW package	108°C/W
Storage temperature range, T _{stg}	

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

- 2. This value is limited to 5.5 V maximum.
- 3. The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 4)

		MIN	MAX	UNIT	
Supply voltage		2‡	5.5	V	
	V _{CC} = 2 V	1.5			
High-level input voltage,	V _{CC} = 2.3 V to 2.7 V	$V_{CC} \times 0.7$.,	
control inputs	V _{CC} = 3 V to 3.6 V	$V_{CC} \times 0.7$		V	
	V _{CC} = 4.5 V to 5.5 V	$V_{CC} \times 0.7$			
	V _{CC} = 2 V		0.5		
Low-level input voltage,	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		$V_{CC} \times 0.3$	V	
control inputs	$V_{CC} = 3 \text{ V to } 3.6 \text{ V}$		$V_{CC} \times 0.3$	v	
	V _{CC} = 4.5 V to 5.5 V		$V_{CC} \times 0.3$		
Control input voltage		0	5.5	V	
Input/output voltage		0	VCC	V	
	$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$		200		
Input transition rise or fall rate	V _{CC} = 3 V to 3.6 V		100	ns/V	
	V _{CC} = 4.5 V to 5.5 V		20		
Operating free-air temperature		-40	105	°C	
	High-level input voltage, control inputs Low-level input voltage, control inputs Control input voltage Input/output voltage Input transition rise or fall rate	High-level input voltage, control inputs $ \begin{array}{c} V_{CC} = 2 \text{ V} \\ V_{CC} = 2.3 \text{ V to } 2.7 \text{ V} \\ V_{CC} = 3 \text{ V to } 3.6 \text{ V} \\ V_{CC} = 4.5 \text{ V to } 5.5 \text{ V} \\ \end{array} $ Low-level input voltage, $ \begin{array}{c} V_{CC} = 2.3 \text{ V to } 2.7 \text{ V} \\ V_{CC} = 2.3 \text{ V to } 2.7 \text{ V} \\ V_{CC} = 3.3 \text{ V to } 3.6 \text{ V} \\ V_{CC} = 3.4 \text{ V to } 5.5 \text{ V} \\ \end{array} $ Control input voltage $ \begin{array}{c} I_{CC} = 2.3 \text{ V to } 2.7 \text{ V} \\ V_{CC} = 4.5 \text{ V to } 5.5 \text{ V} \\ \end{array} $ Input/output voltage $ \begin{array}{c} V_{CC} = 2.3 \text{ V to } 2.7 \text{ V} \\ V_{CC} = 3.4 \text{ V to } 3.6 \text{ V} \\ V_{CC} = 3.4 \text{ V to } 3.6 \text{ V} \\ V_{CC} = 4.5 \text{ V to } 3.6 \text{ V} \\ \end{array} $	Supply voltage	$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	

[‡] With supply voltages at or near 2 V, the analog switch on-state resistance becomes very nonlinear. It is recommended that only digital signals be transmitted at these low supply voltages.

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

			.,	T	λ = 25°C	;			
	PARAMETER	TEST CONDITIONS	VCC	MIN	TYP	MAX	MIN	MAX	UNIT
		I O TA W W OND	2.3 V		38	180		225	
ron	On-state switch resistance	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ or GND},$ $V_{INH} = V_{II}, \text{ (see Figure 1)}$	3 V		30	150		190	Ω
		- IIII - IE, (600 - 1901 - 1)	4.5 V		22	75		100	
		1 2 A V V 4- CND	2.3 V		113	500		600	
ron(p)	Peak on-state resistance	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ to GND},$ $V_{INH} = V_{II}$	3 V		54	180		225	Ω
		THAT TIE	4.5 V		31	100		125	
	Difference in on-state		2.3 V		2.1	30		40	
Δr_{on}	resistance between	$I_T = 2 \text{ mA}, V_I = V_{CC} \text{ to GND},$ $V_{INH} = V_{II}$	3 V		1.4	20		30	Ω
	switches	TIND TIE	4.5 V		1.3	15		20	
Ц	Control input current	V _I = 5.5 V or GND	0 to 5.5 V			±0.1		±1	μΑ
IS(off)	Off-state switch leakage current	$V_I = V_{CC}$ and $V_O = GND$, or $V_I = GND$ and $V_O = V_{CC}$, $V_{INH} = V_{IH}$, (see Figure 2)	5.5 V			±0.1		±1	μА
I _{S(on)}	On-state switch leakage current	V _I = V _{CC} or GND, V _{INH} = V _{IL} (see Figure 3)	5.5 V			±0.1		±1	μА
Icc	Supply current	$V_I = V_{CC}$ or GND	5.5 V					20	μΑ
CIC	Control input capacitance	f = 10 MHz	3.3 V		2				pF
C _{IS}	Common terminal capacitance		3.3 V		23.4				pF
Cos	Switch terminal capacitance		3.3 V		5.7				pF
C _F	Feedthrough capacitance		3.3 V		0.5				pF

switching characteristics over recommended operating free-air temperature range, V_{CC} = 2.5 V \pm 0.2 V (unless otherwise noted)

BAB	AMETER	FROM	то	TEST	T,	չ = 25°C	;	MAIN	MAN	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF, (see Figure 4)		1.9	10		16	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		6.6	18		23	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		7.4	18		23	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF, (see Figure 5)		3.8	12		18	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		7.8	28		35	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		11.5	28		35	ns



SN74LV4051A-EP 8-CHANNEL ANALOG MULTIPLEXER/DEMULTIPLEXER

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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted)

DAD	AMETER	FROM	то	TEST	T,	λ = 25°C	;	84181	MAN	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
t _{PLH}	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF, (see Figure 4)		1.2	6		10	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		4.7	12		15	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		5.7	12		15	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF, (see Figure 4)		2.5	9		12	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		5.5	20		25	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		8.8	20		25	ns

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted)

DAD	AMETER	FROM	то	TEST	TA	√ = 25°C	;	BAIN!	MAN	
PAR	AMETER	(INPUT)	(OUTPUT)	CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNIT
^t PLH ^t PHL	Propagation delay time	COM or Yn	Yn or COM	C _L = 15 pF, (see Figure 4)		0.6	4		7	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		3.5	8		10	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 15 pF, (see Figure 5)		4.4	8		10	ns
tPLH tPHL	Propagation delay time	COM or Yn	Yn or COM	C _L = 50 pF, (see Figure 4)		1.5	6		8	ns
^t PZH ^t PZL	Enable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		4	14		18	ns
^t PHZ ^t PLZ	Disable delay time	INH	COM or Yn	C _L = 50 pF, (see Figure 5)		6.2	14		18	ns

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analog switch characteristics over recommended operating free-air temperature range (unless otherwise noted)

24244555	FROM	то	7707.00	IDITIONS.	.,	T,	ղ = 25°C	;	LINIT		
PARAMETER	(INPUT)	(OUTPUT)	TEST CO	NDITIONS	VCC	MIN	TYP	MAX	UNIT		
			$C_L = 50 \text{ pF},$	C _L = 50 pF,			20				
Frequency response (switch on)	COM or Yn	Yn or COM	$R_L = 600 \Omega$, $f_{in} = 1 MHz$ (sir	ne wave)	3 V		25		MHz		
(cimen city			(see Note 5 and		4.5 V		35				
Crosstalk			C _L = 50 pF,	C _L = 50 pF,			20				
(control input to signal	INH	COM or Yn	$R_L = 600 \Omega$, $f_{in} = 1 \text{ MHz (square wave)}$ (see Figure 7)				3 V		35		mV
output)					4.5 V		60				
			C _L = 50 pF,		2.3 V		-45				
Feedthrough attenuation (switch off)	COM or Yn	Yn or COM	$R_L = 600 \Omega$, $f_{in} = 1 MHz$		3 V		-45		dB		
(Girilan Gir)			(see Note 6 and	d Figure 8)	4.5 V		-45				
			C _L = 50 pF,	V _I = 2 V _{p-p}	2.3 V		0.1				
Sine-wave distortion	COM or Yn	Yn or COM	$R_L = 10 \text{ k}\Omega$, $f_{\text{in}} = 1 \text{ kHz}$	V _I = 2.5 V _{p-p}	3 V		0.1		%		
			(sine wave) (see Figure 9)	V _I = 4 V _{p-p}	4.5 V		0.1				

NOTES: 5. Adjust f_{in} voltage to obtain 0-dBm output. Increase f_{in} frequency until dB meter reads -3 dB.

operating characteristics, $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$

	PARAMETER	TEST CON	TYP	UNIT	
C _{pd}	Power dissipation capacitance	C _L = 50 pF,	f = 10 MHz	5.9	pF

PARAMETER MEASUREMENT INFORMATION

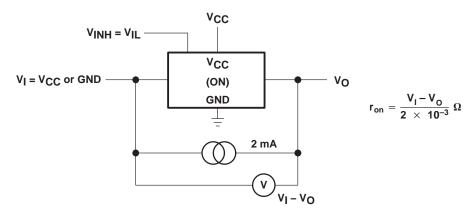
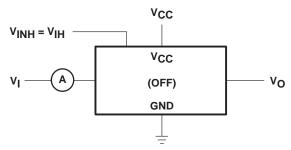


Figure 1. On-State Resistance Test Circuit

^{6.} Adjust fin voltage to obtain 0-dBm input.

PARAMETER MEASUREMENT INFORMATION



Condition 1: $V_I = 0$, $V_O = V_{CC}$ Condition 2: $V_I = V_{CC}$, $V_O = 0$

Figure 2. Off-State Switch Leakage-Current Test Circuit

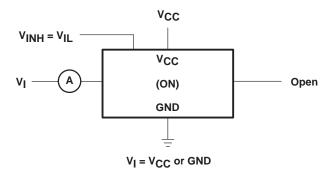


Figure 3. On-State Switch Leakage-Current Test Circuit

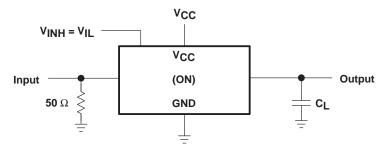


Figure 4. Propagation Delay Time, Signal Input to Signal Output

PARAMETER MEASUREMENT INFORMATION

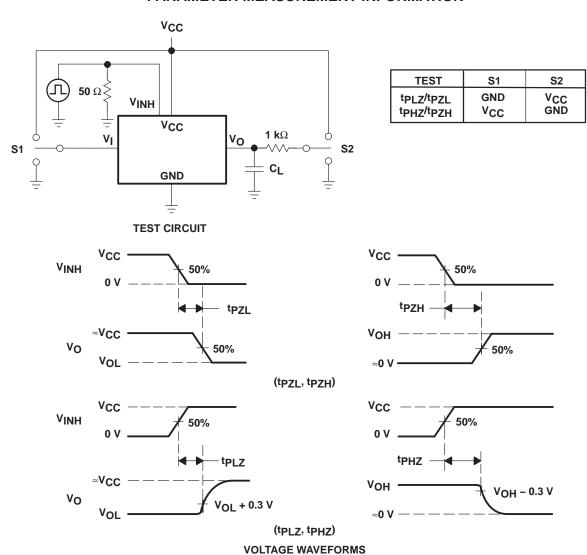


Figure 5. Switching Time (t_{PZL}, t_{PLZ}, t_{PZH}, t_{PHZ}), Control to Signal Output

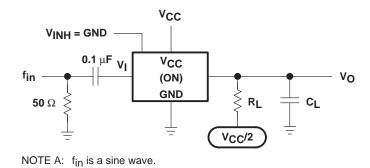


Figure 6. Frequency Response (Switch On)



PARAMETER MEASUREMENT INFORMATION

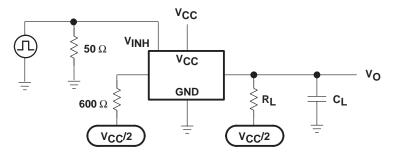


Figure 7. Crosstalk (Control Input, Switch Output)

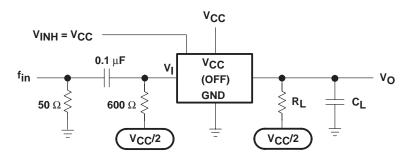


Figure 8. Feedthrough Attenuation (Switch Off)

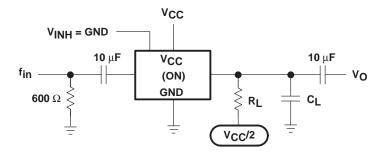


Figure 9. Sine-Wave Distortion





31-May-2014

PACKAGING INFORMATION

Orderable Device	Status	Package Type	_	Pins	_	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
SN74LV4051ATDREP	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 105	LV4051ATEP	Samples
SN74LV4051ATPWREP	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 105	L4051EP	Samples
V62/03664-01XE	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 105	L4051EP	Samples
V62/03664-01YE	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 105	LV4051ATEP	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.



PACKAGE OPTION ADDENDUM

31-May-2014

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OTHER QUALIFIED VERSIONS OF SN74LV4051A-EP:

Catalog: SN74LV4051A

Automotive: SN74LV4051A-Q1

NOTE: Qualified Version Definitions:

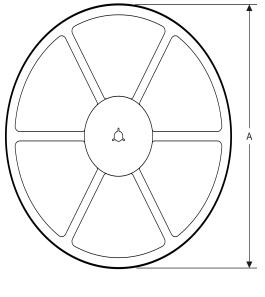
- Catalog TI's standard catalog product
- Automotive Q100 devices qualified for high-reliability automotive applications targeting zero defects

PACKAGE MATERIALS INFORMATION

14-Jul-2012 www.ti.com

TAPE AND REEL INFORMATION

REEL DIMENSIONS





TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV4051ATDREP	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
SN74LV4051ATPWREP	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

www.ti.com 14-Jul-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV4051ATDREP	SOIC	D	16	2500	333.2	345.9	28.6
SN74LV4051ATPWREP	TSSOP	PW	16	2000	367.0	367.0	35.0

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